TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type (U-MOSⅢ)

TPCP8203

Portable Equipment Applications

Motor Drive Applications

DC/DC Converters

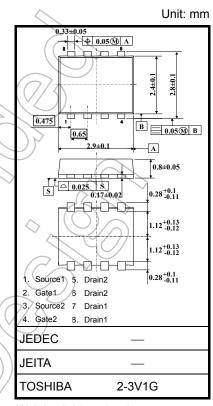
- Lead (Pb)-free
- Small footprint due to small and thin package
- Low drain-source ON-resistance: $R_{DS(ON)}$ = 31 m Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 8.6 \text{ S}$ (typ.)
- Low leakage current: I_{DSS} = 10 μA (max)(V_{DS} = 40 V)
- Enhancement model: V_{th} = 1.3 to 2.5V
 - $(V_{DS} = 10 \text{ V}, I_{D} = 1 \text{ mA})$

Absolute Maximum Ratings (Ta = 25°C)

Characteristic		Symbol	Rating	Unit
Drain-source voltage		V _{DSS}	40	V
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V _{DGR}	40	V
Gate-source voltage		VGSS	±20	V
Drain current	DC (Note 1)	ID	4.7	A
Drain current	Pulse (Note 1)	IDP	18.8	
Drain power dissipation	Single-device operation (Note 3a)	P _D (1)	1.48	
(t = 5 s) (Note 2a)	Single-device value at dual operation (Note 3b)	PD (2)	1.23	w
Drain power dissipation (t = 5 s) (Note 2b)	Single-device operation (Note 3a)	P _D (1)	0.58	
	Single-device value at dual operation (Note 3b)	P _{D (2)}	0.36	
Single-pulse avalanche energy (Note 4)		EAS	10.6	mJ
Avalanche current		IAR	4.7	А
Repetitive avalanche energy Single-device value at dual operation (Note 2a, 3b, 5)		EAR	0.12	mJ
Channel temperature		T _{ch}	150	°C
Storage temperature range		T _{stg}	T _{stg} –55 to 150	

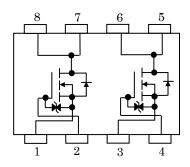
Note: For Notes 1 to 6, see the next page.

This transistor is an electrostatic-sensitive device. Handle with care.

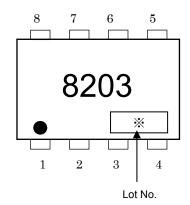


Weight: 0.017 g (typ.)

Circuit Configuration



Marking (Note 6)

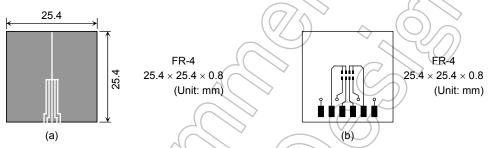


Thermal Characteristics

Characteristic		Symbol	Max	Unit	
Thermal resistance, channel to ambient (t = 5 s) (Note 2a	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	84.5	°C/W	
	Single-device value at dual operation (Note 3b)	R _{th} (ch-a) (2)	101.6		
Thermal resistance,	Single-device operation (Note 3a)	R _{th (ch-a) (1)} 215.5		°C/W	
channel to ambient (t = 5 s) (Note 2b)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	347.2	0/22	

Note 1: Ensure that the channel temperature does not exceed 150°C,

Note 2: (a) Device mounted on a glass-epoxy board (a)



(b) Device mounted on a glass-epoxy board (b)

Note 3: a) The power dissipation and thermal resistance values shown are for a single device. (During single-device operation, power is applied to one device only.)

- b) The power dissipation and thermal resistance values shown are for a single device. (During dual operation, power is applied to both devices evenly.).
- Note 4: $V_{DD} = 25 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}$ (initial), $L = 0.5 \text{ mH}, \text{ R}_{G} = 25 \Omega, \text{ I}_{AR} = 4.7 \text{ A}$
- Note 5: Repetitive rating: Pulse width limited by Max. Channel temperature.
- Note 6: on the lower left of the marking indicates Pin 1.
 - * Weekly code (3 digits):

Week of manufacture

(01 for the first week of the year, continuing up to 52 or 53)

Year of manufacture

(The last digit of the calendar year)

Note 7: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Electrical Characteristics (Ta = 25°C)

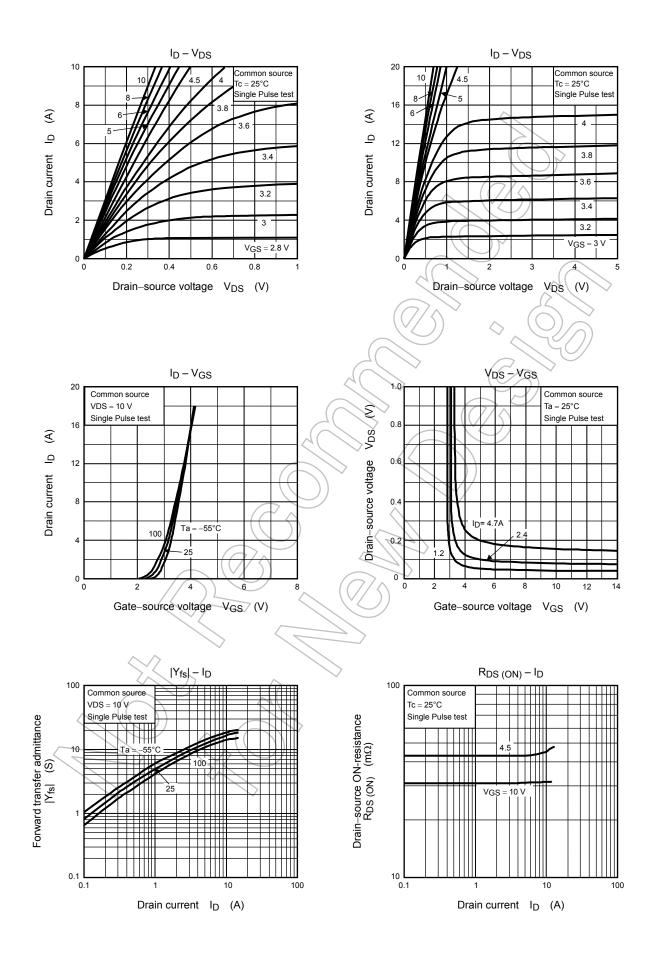
Characteristic		Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage cu	rrent	I _{GSS}	$V_{GS}=\pm 16~V,~V_{DS}=0~V$	_		±10	μA	
Drain cutoff curre	ent	I _{DSS}	$V_{DS} = 40 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	_	_	10	μA	
Drain-source breakdown voltage		V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	40		_	V	
		V (BR) DSX	$I_D = 10 \text{ mA}, V_{GS} = -20 \text{ V}$	15	_	_		
Gate threshold voltage		V _{th}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$	1.3	\rightarrow	2.5	V	
Drain-source ON-resistance		R _{DS (ON)}	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 2.4 \text{ A}$	X	43	60		
		R _{DS (ON)}	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 2.4 \text{ A}$	74	31	40	mΩ	
Forward transfer admittance		Y _{fs}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 2.4 \text{ A}$	4.3	8.6		S	
Input capacitance		C _{iss}		_	770			
Reverse transfer capacitance		C _{rss}	$V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$	_	70		pF	
Output capacitance		C _{oss}	- 105		_			
Switching time	Rise time	tr	$V_{GS} \stackrel{10 V}{_{0 V}} \prod \stackrel{I_D=2:4 A}{_{0 V}} Output$	- (8		~	
	Turn-on time	ton			15) —	- ns	
	Fall time	tf	V _{DD} ≃ 20 V	200	9	_		
	Turn-off time	t _{off}	Duty $\leq 1\%$, $t_w = 10 \ \mu s$	Ì	70	_		
Total gate charge (gate-source plus gate-drain)		Qg	V _{DD} = 32 V, V _{GS} = 10 V,)	16			
Gate-source charge1		Q _{gs1}	$I_D = 4.7 \text{ A}$	_	2.5	_	nC	
Gate-drain ("Miller") charge		Q _{gd}			4			

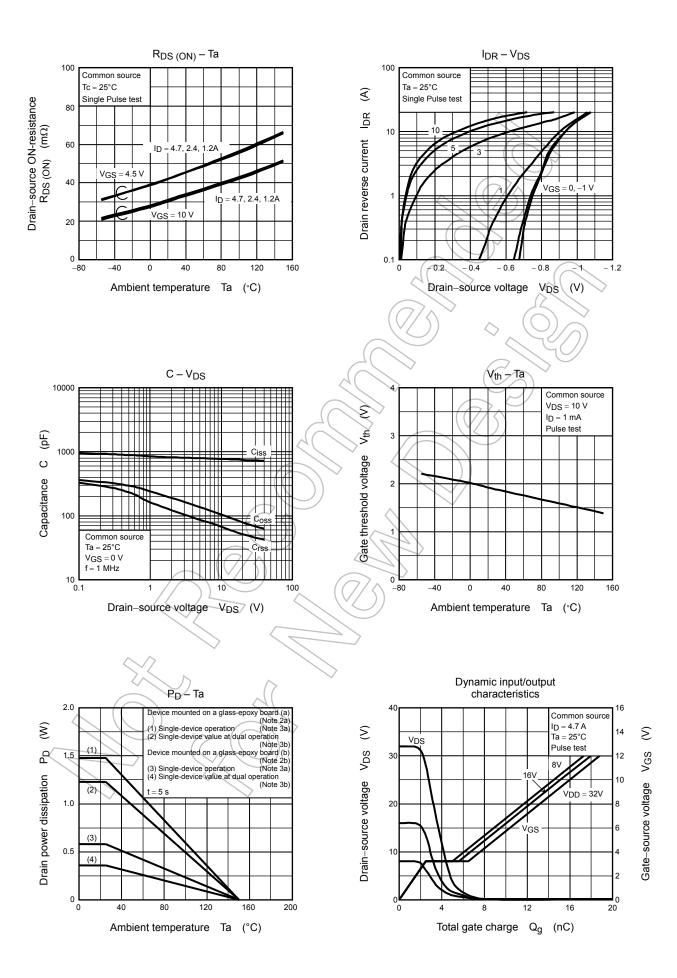
Source-Drain Ratings and Characteristics (Ta = 25°C)

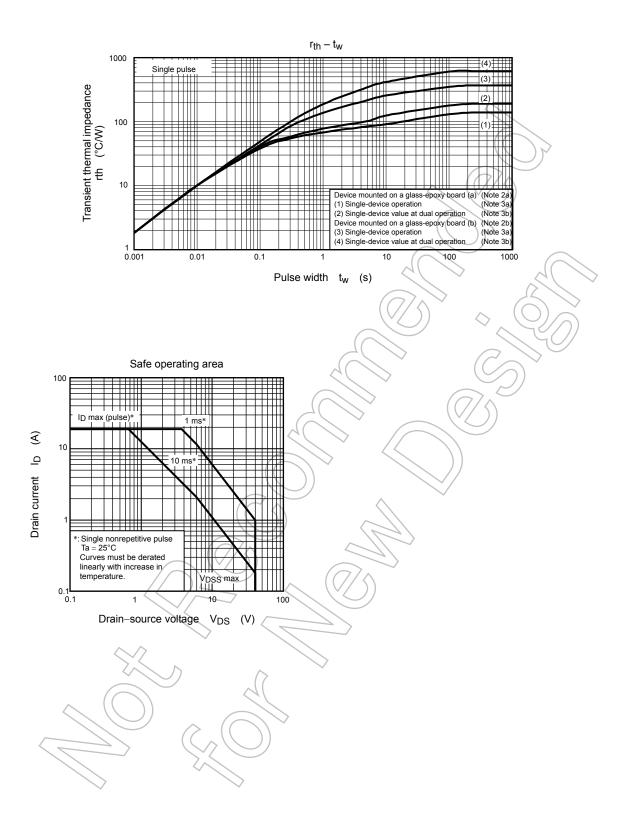
Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current Pulse (Note 1)	IDRP	(\vee) –	_	_	18.8	А
Forward voltage (diode)	VDSF	$I_{DR} = 4.7 \text{ A}, V_{GS} = 0 \text{ V}$			-1.2	V



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